

CAS 125 Array Spectrometer

Productivity and Reliability

Key features at a glance

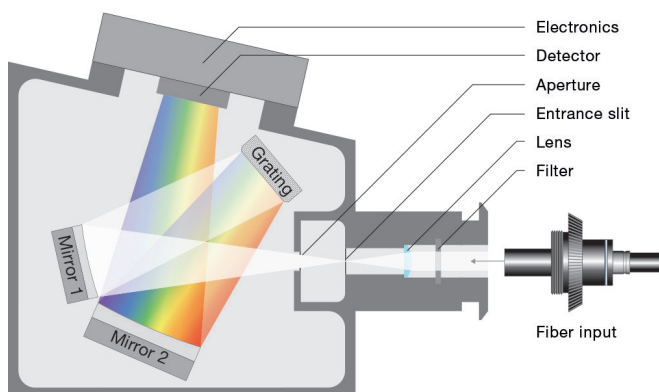
- ▲ Very short integration times down to 10 μ s
- ▲ 2048 pixels CMOS sensor with thermal stabilization
- ▲ Recipe Mode for ultrafast measurement sequences
- ▲ Max. scan rate of 3700/s
- ▲ Robust housing with smaller footprint



The new CAS 125 extends the series of well-established high-performance spectroradiometers from Instrument Systems into the field of price-sensitive applications such as LED production testing and quality assurance. The “plug & play” function allows a high degree of process reliability. The system automatically recognizes the connected accessories and ensures that only current and valid calibrations are used. The novel recipe mode significantly increases productivity in time-critical high-throughput applications.

\\ PROVEN OPTICAL SETUP

A crossed Czerny-Turner spectrograph forms the core of the CAS 125. The optical setup is adopted from the proven CAS 140D which is the undisputed industry standard for laboratory applications. This design guarantees maximum optical precision with exceptionally good stray light rejection.



▲ *Optical setup of the CAS 125 with optimized crossed Czerny-Turner Spectrograph.*

\\ VERSATILE IN APPLICATION

Unique technical innovations integrated in the CAS 125 result in a high level of reliability and speed. A thermal stabilization of the sensor ensures operation independent from changing environmental conditions. Model variants ranging from 200 nm up to 1100 nm and the high-quality optical setup guarantee precise results for diverse measurement tasks. The economic design with a robust housing and smaller footprint is specially designed for the demanding conditions experienced in 24/7 operation.

The new CAS 125 satisfies the high requirements on accuracy and versatility from high-volume production applications to diverse laboratory tasks.

Model Information		
Model	Slit	Filter wheel
[151] VIS (360 - 830 nm)	Options are 50 μ m, 100 μ m and 250 μ m	Various filter-wheel combinations are available (OD 0.5 to OD 4; max. 7 filters)
[153] VIS/NIR (380 - 1040 nm)		
[154] UV/VIS/NIR (220 - 1020 nm)		
[156] UV/VIS/NIR (300 - 1100 nm)		
[157] UV/VIS (200 - 830 nm)		

\\ EXTENSIVE SOFT- & HARDWARE PACKAGE

The CAS 125 is equipped with Ethernet interface and hardware trigger. The integrated density filter wheel and the dark-current shutter additionally facilitate fully automated measurements over an extremely broad signal range. A software development kit (SDK) with DLL driver allows fast and easy integration of the CAS 125 into production environment. In addition, SpecWin Pro and SpecWin Light provide an extensive range of spectral analysis tools and hardware interfaces for diverse laboratory tasks.

\\ “RECIPE MODE” FOR ULTRAFAST MEASUREMENT SEQUENCES

The DLL enables the merging of several thousand measurements into combined recipes, which are loaded onto the CAS 125 upon execution. The subsequent measurements are carried out step-by-step in a hardware-triggered mode avoiding long communication times with the computer between successive measurements. Thanks to an internal buffer and parallel readout of the test data, the recipe can be carried out with minimum delay time, which drastically enhances the units-per-hour in production environments.

\\ TECHNICAL SPECIFICATIONS

CAS 125 Array Spectrometer			
Model	UV/VIS	VIS	UV/VIS/NIR
Spectral range	200 – 830 nm	360 – 830 nm	220 – 1020 nm / 300 – 1100 nm
Detector ¹⁾	CMOS		
Number of pixels ²⁾	2048		
Spectral resolution 100 µm slit width	3.0 nm	2.2 nm	3.7 nm
Data point interval	0.72 nm	0.53 nm	0.91 nm
Wavelength accuracy	±0.2 nm		
Integration time	10 µs – 10 sec		
Shortest duration SOT to EOT	280 µs		
SOT to SOT (Recipe Mode) ³⁾	550 µs		
Max. scan rate ⁴⁾	3700 scans/sec		
Dynamic range ⁵⁾	7000:1		
Non-Linearity	±0.6 %		
Stray Light			
Broadband for Illuminant A ⁶⁾	7*10 ⁻⁴	5*10 ⁻⁴	7*10 ⁻⁴
For LED ⁷⁾	1*10 ⁻⁴		
With Laser ⁸⁾	5*10 ⁻⁵		
Sensitivity			
Measuring range Irradiance ⁹⁾	0.3 µW/m ² nm - 200 kW/m ² nm	0.2 µW/m ² nm - 100 kW/m ² nm	0.1 µW/m ² nm - 90 kW/m ² nm
Measuring range Luminous intensity ¹⁰⁾	60 µcd - 40 Mcd	40 µcd - 30 Mcd	30 µcd - 20 Mcd
Measuring range Luminous flux ¹¹⁾	0.3 mlm - 100 Mlm	0.2 mlm - 100 Mlm	0.2 mlm - 80 Mlm
Spectrophotometry			
Baseline noise ¹²⁾	0.25 %		
Transmission measuring accuracy ¹³⁾	0.8 s%		
Baseline drift ¹⁴⁾	0.2 Counts/h		

\\ TECHNICAL SPECIFICATIONS

CAS 125 Array Spectrometer			
Model	UV/VIS	VIS	UV/VIS/NIR
Spectrograph			
Focal length, f number, grating	Approx. 120 mm, f/3.5, plane reflection grating		
Slit	Standard: 100 µm; optional: 50 µm, 250 µm		
Filter wheel / shutter	Max. 7 slots for density filters OD 0.5 to OD 4; UV/VIS and UV/VIS/NIR with UV density filters; position monitoring with encoder		
Electrical data			
AD converter	16 bit resolution		
PC interface	Ethernet		
Triggering	Input: 5V TTL ascending slope; output: 2 TTL outputs		
Miscellaneous			
Dimensions (H x W x D)	136.5 mm x 233 mm x 325 mm		
External Power supply	Wide-range input (external) 100 VAC to 240 VAC 50/60 Hz		
Device Power supply	24 Vdc		
Power consumption	36 VA		
Ambient temperature	15 – 35°C; relative humidity 70% max., non-condensing		
Weight	6.6 kg		
Valid standards	In conformity with CE (2014/30/EU, 2011/65/EU, 2012/19/EU), FCC Part15B, KC		
Measurement uncertainty ¹⁵⁾			
Accuracy ¹⁶⁾			
Luminance / Radiance	4.00 %		
Luminous Intensity / Flux	5.00 %		
Irradiance / Illuminance	4.50 %		
Color coordinates (x,y) ¹⁷⁾	0.002		
Dominant wavelength ¹⁸⁾	0.6 nm		
Instrument precision			
Rad. Int. ¹⁹⁾	0.30 %	0.30 %	0.30 %
Pho Int	0.50 %	0.35 %	0.50 %
Color coordinates (x,y)	0.0018	0.0018	0.0018
Dominant wavelength	0.12 nm	0.30 nm	0.12 nm

¹⁾ Sensor with thermal stabilization.

²⁾ Binned to 1024 data points.

³⁾ Measured with a Keithley A and a computer system B under measurement condition C.

⁴⁾ Depends on integration time, device settings and performance of operating computer / system.

⁵⁾ Single acquisition with 1 ms integration time.

⁶⁾ Measured with edge filter OG455 at 400 nm, relative to peak intensity of unweighted spectral data.

⁷⁾ Measured 150 nm to left of the peak wavelength, relative to peak intensity of unweighted spectral data.

⁸⁾ Measured 150 nm to left of the peak wavelength, relative to peak intensity of unweighted spectral data.

⁹⁾ Measured with optical probe EOP-120 and OFG-414 fiber bundle at 600nm and signal/noise ratio of 10:1, without averaging.

¹⁰⁾ Applies to a signal-to-noise ratio of 10:1. Measured with LED-436/437 adapter. Upper limit calculated.

¹¹⁾ Applies to a signal-to-noise ratio of 10:1. Measured with integrating sphere ISP150L. Upper limit calculated.

¹²⁾ With shortest integration time, without averaging and with 50% modulation. This value improves with appropriate averaging (e.g. 9x averaging results in a 3x reduction of noise).

¹³⁾ Applies to optimum spectral range; with 10% transmission and immediately after recording an averaged baseline.

¹⁴⁾ Typical value. Applies with LS100-130 light source after 2 hour warm-up at constant ambient conditions.

¹⁵⁾ Minimum achievable, extended relative measuring uncertainty applied to a twofold standard deviation. Only applies to the measuring and ambient conditions used for calibration (e.g. without density filter, optimum spectral range, sufficient signal level, etc).

¹⁶⁾ For int.time >1ms or >100 averages.

¹⁷⁾ For white LED.

¹⁸⁾ For red LED.

¹⁹⁾ Evaluation range limited to ±50nm of peak wavelength.

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